



ZXMN6A08K

60V DPAK N-channel enhancement mode MOSFET

Summary

V _{(BR)DSS}	$R_{DS(on)}$ (Ω)	I _D (A)
60	0.080 @ V _{GS} = 10V	18.2
	0.150 @ V _{GS} = 4.5V	13.3



Description

DPAK

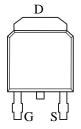
This new generation Trench MOSFET from Zetex features a unique structure combining the benefits of low on-resistance and fast switching, making it ideal for high efficiency power management applications.

Features

- · Low on-resistance
- · Fast switching speed
- · Low gate drive
- DPAK package

Applications

- DC-DC Converters
- Power Management functions
- Disconnect switches
- Motor control



Pinout – top view

Ordering information

Device	Reel size (inches)	Tape width (mm)	Quantity per reel
ZXMN6A08KTC	13	16	2,500

Device marking

ZXMN

6A08

Absolute maximum ratings

PARAMETER	SYMBOL	LIMIT	UNIT
Drain-Source Voltage	V _{DSS}	60	V
Gate-Source Voltage	V _{GS}	±20	٧
Continuous Drain Current @ V _{GS} =10V; T _C =25°C (e)	I _D	18.2	А
@ $V_{GS}=10V; T_{C}=100^{\circ}C$ (e)		11.5	
Continuous Drain Current @ V _{GS} =10V; T _A =25°C (b)	I _D	8.1	Α
@ $V_{GS}=10V; T_A=70^{\circ}C$ (b)		6.5	
@ $V_{GS}=10V; T_A=25^{\circ}C$ (a)		5.5	
Pulsed Drain Current (c)	I _{DM}	24.3	А
Continuous Source Current (Body Diode) (b)	Is	9.0	А
Pulsed Source Current (Body Diode) (c)	I _{SM}	24.3	А
Power Dissipation at T _A =25°C (a)	P _D	4.1	W
Linear Derating Factor		32.8	mW/°C
Power Dissipation at T _A =25°C (b)	P _D	9.25	W
Linear Derating Factor		74	mW/°C
Power Dissipation at T _A =25°C (d)	P _D	2.11	W
Linear Derating Factor		16.8	mW/°C
Operating and Storage Temperature Range	T_j , T_{stg}	-55 to +150	°C

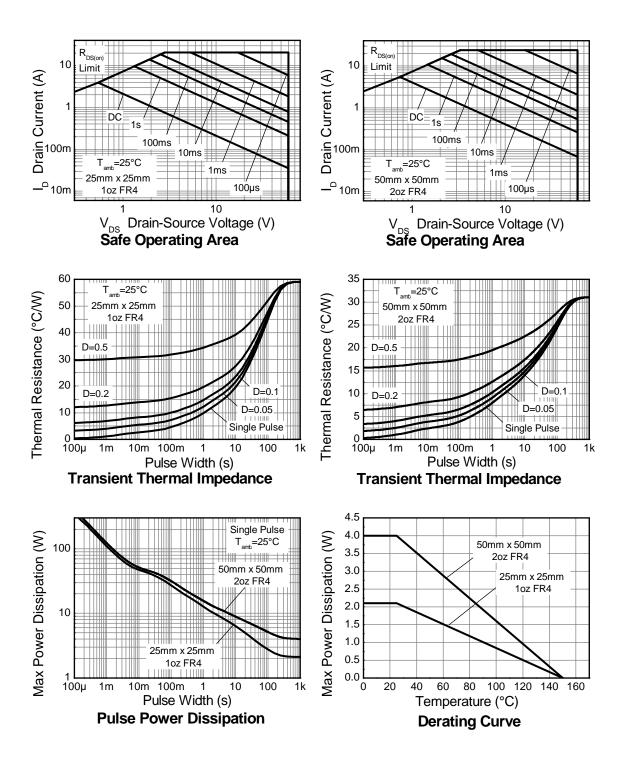
Thermal resistance

PARAMETER	SYMBOL	VALUE	UNIT
Junction to Ambient (a)	$R_{\theta JA}$	30.5	°C/W
Junction to Ambient (b)	$R_{\theta JA}$	14.0	°C/W
Junction to Ambient (d)	$R_{\theta JA}$	59.1	°C/W
Junction to Case (e)	R _{eJC}	2.77	°C/W

NOTES

- (a) For a device surface mounted on 50mm x 50mm x 1.6mm FR4 PCB with high coverage of single sided 2oz copper, in still air conditions.
- (b) For a device surface mounted on FR4 PCB measured at $t \le 10$ sec.
- (c) Repetitive rating 50mm x 50mm x 1.6mm FR4 PCB, D=0.02 pulse width=300μs pulse width limited by maximum junction temperature.
- (d) For a device surface mounted on 25mm x 25mm x 1.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions.
- (e) The terms case and case temperature refer to the exposed metal back face of the package and the drain pin.

Thermal characteristics

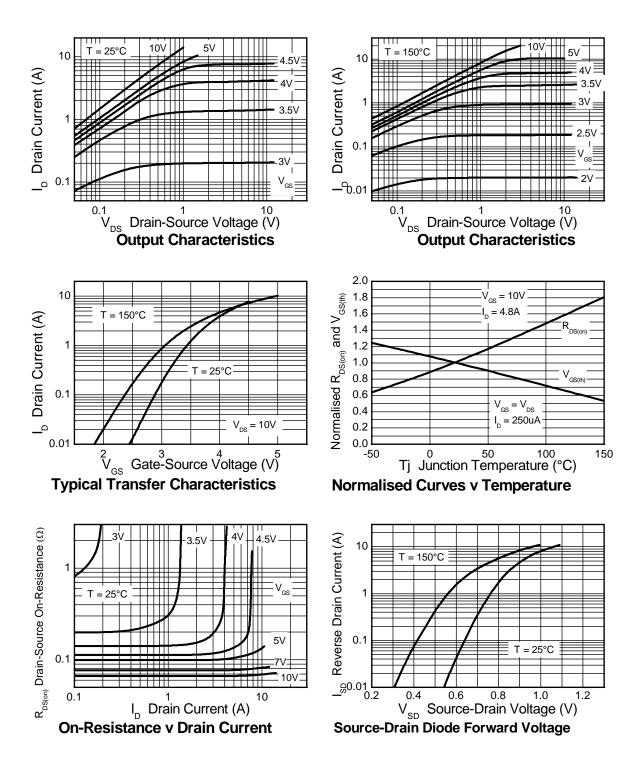


Electrical characteristics (at $T_{amb} = 25$ °C unless otherwise stated).

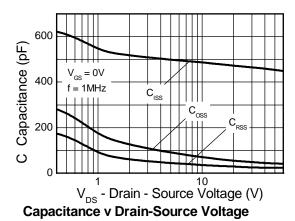
PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT	CONDITIONS
STATIC		•	•	•	•	•
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	60			V	I _D = 250μA, V _G S=0V
Zero Gate Voltage Drain Current	I _{DSS}			0.5	μА	V _{DS} = 60V, V _{GS} =0V
Gate-Body Leakage	I_{GSS}			100	nA	V _{GS} =±20V, V _{DS} =0V
Gate-Source Threshold Voltage	$V_{GS(th)}$	1		3	V	I _D = 250μA, V _{DS} =V _{GS}
Static Drain-Source On-State Resistance (1)	R _{DS(on)}			0.080	Ω	VGS= 10V, ID= 4.8A
(1)				0.150	Ω	VGS= 4.5V, ID = 4.2A
Forward Transconductance (1) (3)	g fs		6.6		S	V _{DS} = 15V, I _D = 4.8A
DYNAMIC (3)						
Input Capacitance	C _{iss}		459		pF	V _{DS} = 40V, V _{GS} =0V
Output Capacitance	C _{oss}		44.2		pF	f=1MHz
Reverse Transfer Capacitance	C _{rss}		24.1		pF	
SWITCHING (2) (3)						
Turn-On-Delay Time	t _{d(on)}		2.6		ns	V _{DD} = 30V, I _D = 1.5A
Rise Time	t _r		2.1		ns	RG≅6.0Ω, VGS= 10V
Turn-Off Delay Time	t _{d(off)}		12.3		ns]
Fall Time	t _f		4.6		ns	
Gate Charge	Q_g		4.0		nC	V _{DS} = 30V, V _{GS} = 5V
						I _D = 1.4A
Total Gate Charge	Q_g		5.8		nC	V _{DS} = 30V, V _{GS} = 10V
Gate-Source Charge	Q_{gs}	<u> </u>	1.4		nC	I _D = 1.4A
Gate Drain Charge	Q_{gd}		1.9		nC	
SOURCE-DRAIN DIODE		•	•		-	_
Diode Forward Voltage (1)	V_{SD}		0.88	0.95	V	Tj=25°C, IS= 4A, VGS=0V
Reverse Recovery Time (3)	t _{rr}		19.2		ns	T _j =25°C, I _S = 1.4A,
Reverse Recovery Charge (3)	Q_{rr}		30.3		nC	di/dt=100A/μs

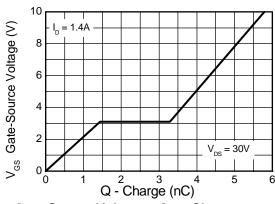
 $[\]begin{array}{ll} \hbox{(1)} & \text{Measured under pulsed conditions. Pulse width} \leq 300 \mu s; \ \text{duty cycle} \leq \!\!\! 2\%. \\ \hbox{(2)} & \text{Switching characteristics are independent of operating junction temperature.} \\ \hbox{(3)} & \text{For design aid only, not subject to production testing.} \\ \end{array}$

Typical Characteristics

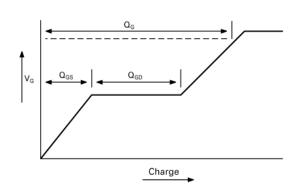


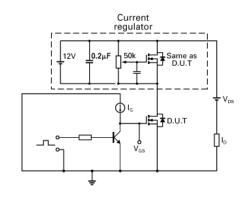
Typical characteristics





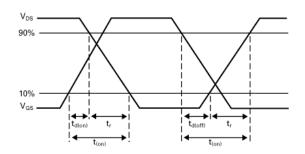
Gate-Source Voltage v Gate Charge

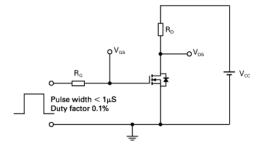




Basic gate charge waveform

Gate charge test circuit



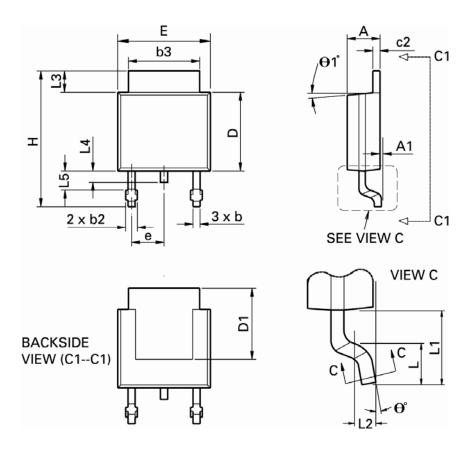


Switching time waveforms

Switching time test circuit

Packaging details - DPAK

Surface mounted, 4 pin package



DIM	Inc	hes	Millin	Millimeters DIM Inches Millime		Inches		neters		
	Min	Max	Min	Max		Min	Max	Min	Max	
Α	0.086	0.094	2.18	2.39	е	0.090 BSC		2.29	2.29 BSC	
A1	-	0.005	-	0.127	Н	0.370	0.410	9.40	10.41	
b	0.020	0.035	0.508	0.89	L	0.055	0.070	1.40	1.78	
b2	0.030	0.045	0.762	1.14	L1	0.108	REF	2.74	REF	
b3	0.205	0.215	5.21	5.46	L2	0.020	BSC	0.508	BSC	
С	0.018	0.024	0.457	0.61	L3	0.035	0.065	0.89	1.65	
c2	0.018	0.023	0.457	0.584	L4	0.025	0.040	0.635	1.016	
D	0.213	0.245	5.41	6.22	L5	0.045	0.060	1.14	1.52	
D1	0.205	-	5.21	-	q1°	0°	10°	0°	10°	
Е	0.250	0.265	6.35	6.73	q°	0°	15°	0°	15°	
E1	0.170	-	4.32	-	-	-	-	-	-	

Note: Controlling dimensions are in inches. Approximate dimensions are provided in millimeters

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Future device intended for production at some point. Samples may be available

Product status	key:
"Preview"	
"Active"	

Product status recommended for new designs "Last time buy (LTB)" Device will be discontinued and last time buy period and delivery is in effect Device is still in production to support existing designs and production "Not recommended for new designs'

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Datasheet status key:

This term denotes a very early datasheet version and contains highly provisional "Draft version

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This term denotes a pre-release datasheet. It provides a clear indication of anticipated performance. "Provisional version" However, changes to the test conditions and specifications may occur, at any time and without notice.

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Sales offices

"Issue"

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